

Threat-Based Metrics for Continuous Enterprise Network Security Management

Richard Lippmann and James Riordan MIT Lincoln Laboratory Lexington, MA 02420-9108 {lippmann,james.riordan}@ll.mit.edu

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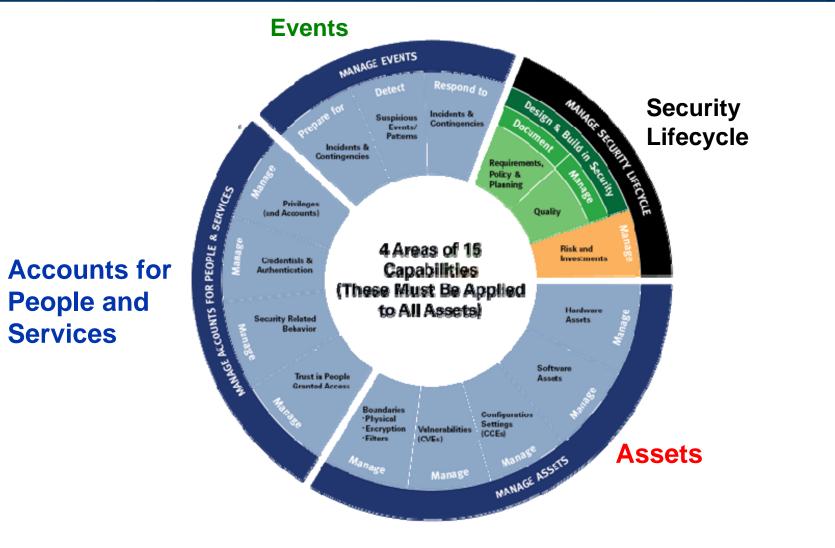
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- Introduction to Continuous Diagnostics and Mitigation
 - Metric Overview
 - Limitations of prior metrics
 - Metric LR-1: Attacker scanning for unauthorized devices
 - Metric LR-3: Attackers exploiting known vulnerabilities
 - Summary and future plans



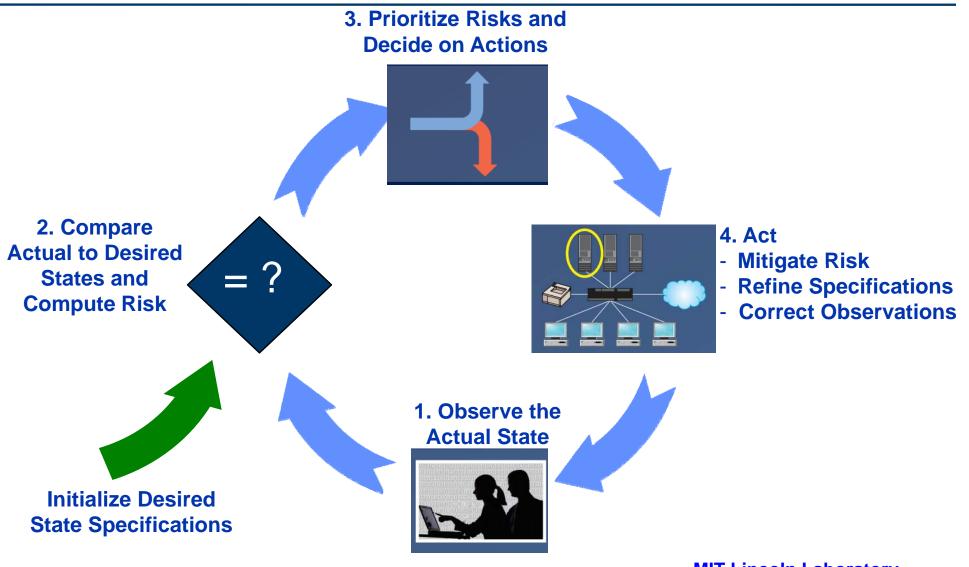
15 Security Capabilities that Must be Managed (U.S. Department of Homeland Security)



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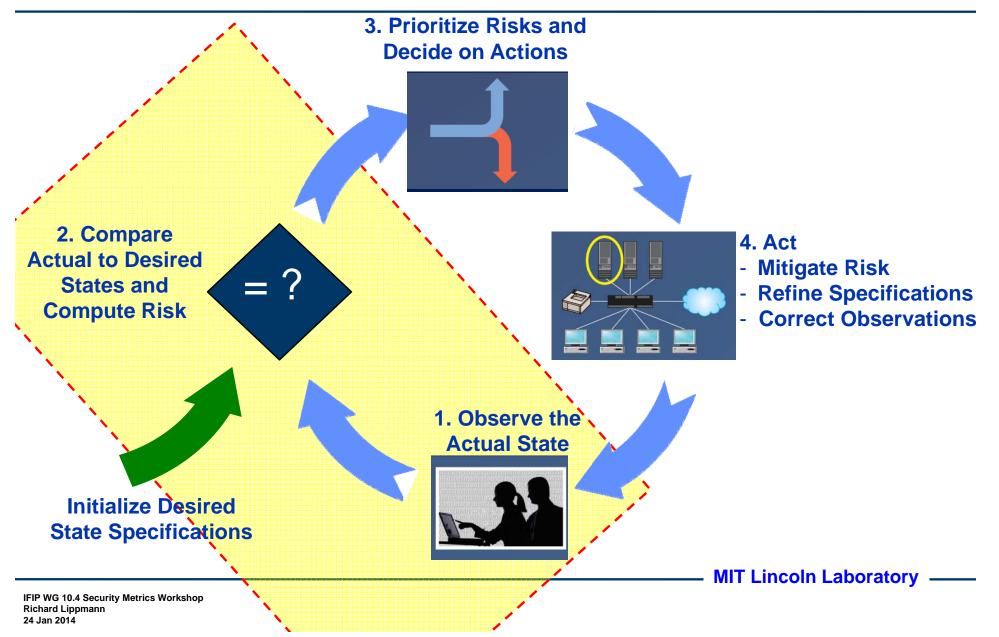
A Continuous Diagnostics and Mitigation (CDM) Process Controls Risk for Each Capability



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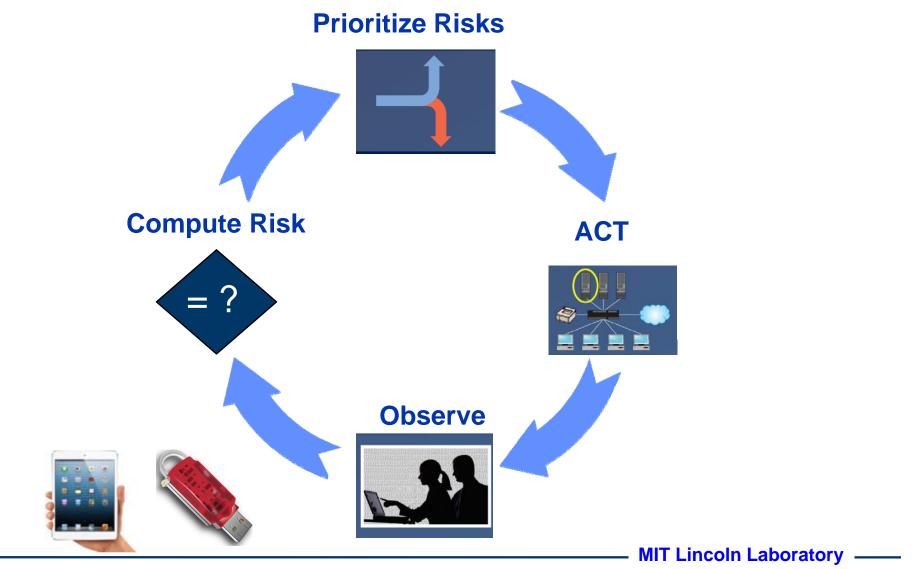


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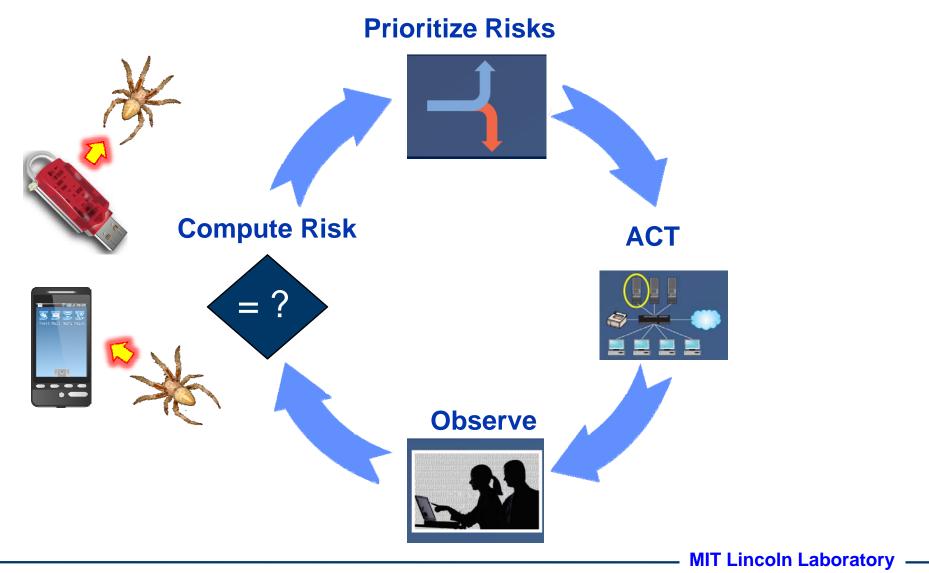


One Example is Managing the Use of Unauthorized Devices on a Network





Attackers can Either Observe and Compromise Insecure Devices or Spread from Already Infected Devices

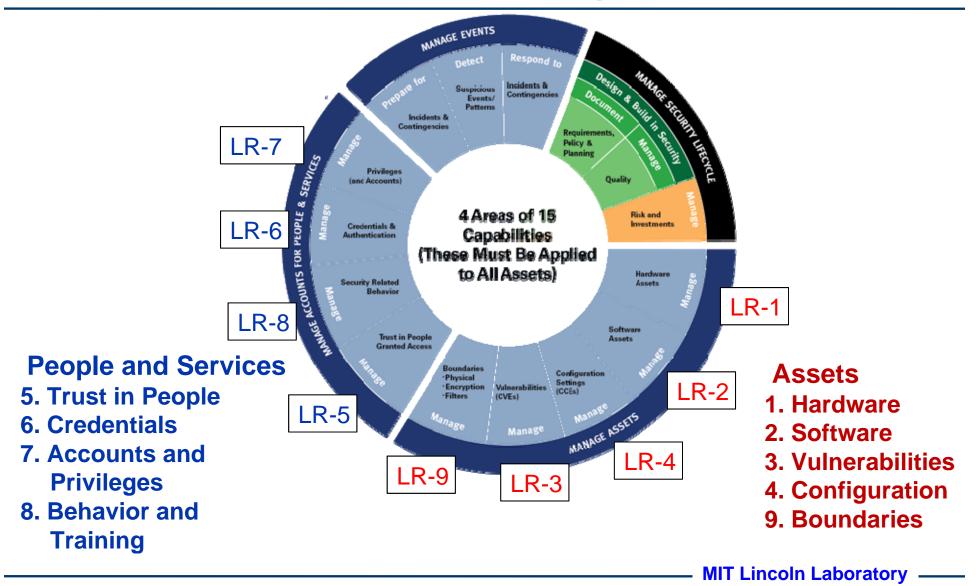




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We Have Created Metrics for Nine of Fifteen Capabilities



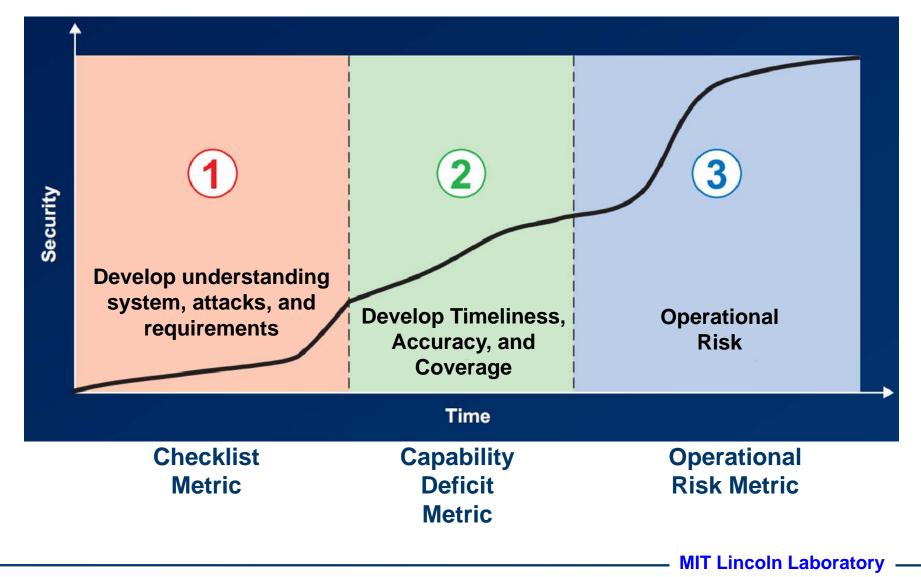


Each Metric Focuses on the Most Important Attack(s) for one Capability



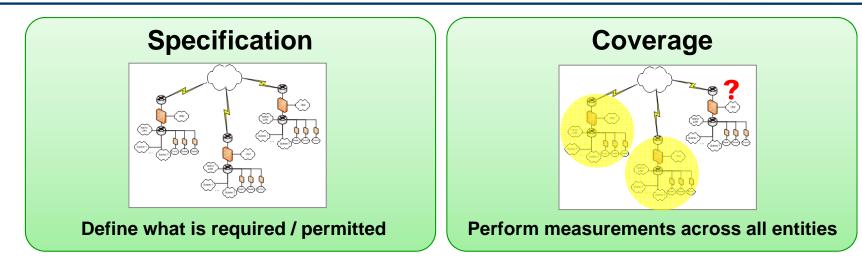


A Three-Stage Security Metric Maturity Model

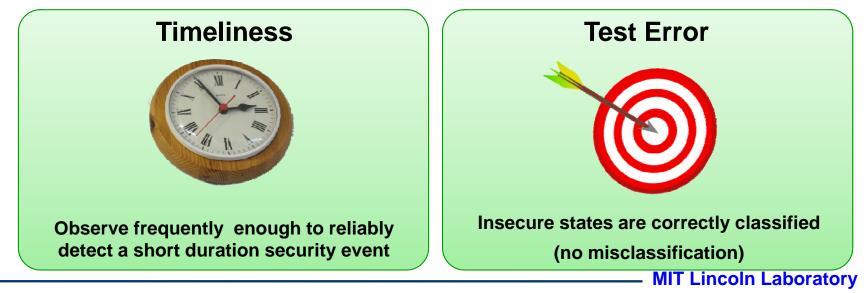




Level 2 Capability Deficit Metrics Determine If Risk Can Be Computed Accurately



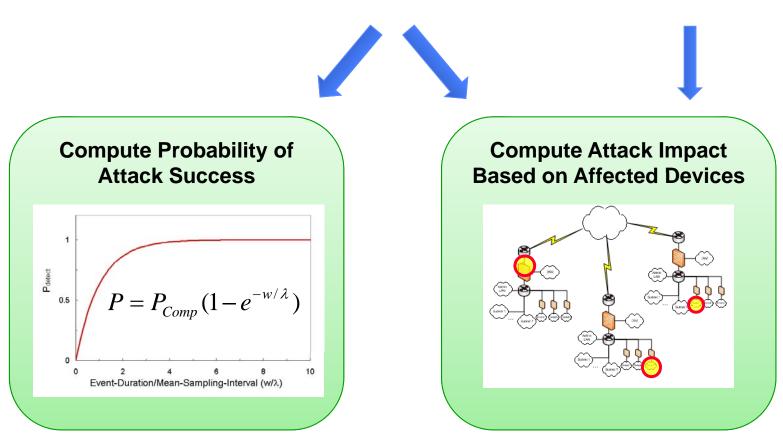
There are few standard aspects to the Capability Deficit metric...





Level 3 Operational Risk Metrics Estimate the Risk Based on the Observed State

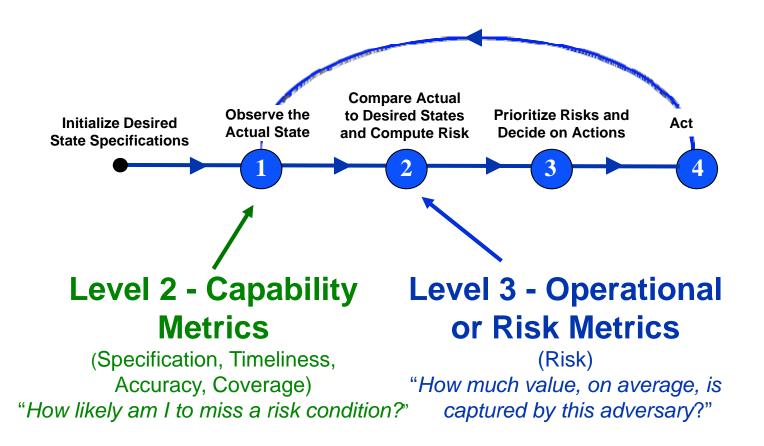
Risk = Probability of Successful Attack x Impact



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Metric Computation is Embedded in and Enables Continuous Diagnostics and Mitigation



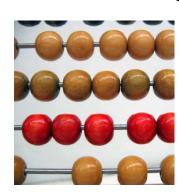
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Existing Risk Metrics Can Not be Used in a Real-Time Diagnostic and Mitigation Loop



- Count- and percentage-based assessments do not model attackers correctly
 - Percentage of devices behind firewall / with anti-virus software
 - Mean / median lag of patch installation

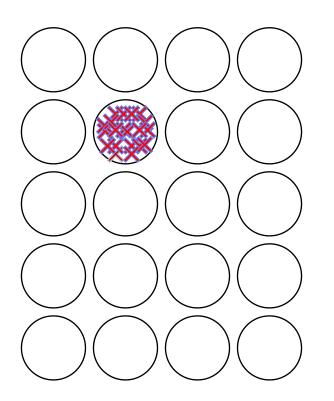


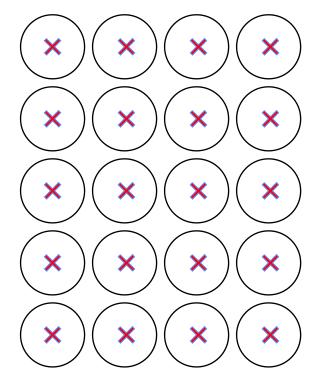
- Other approaches are subjective and can't be automated
 - Annual Loss Expectancy = (Annual Rate)×(Loss)
 - Business Adjusted Risk = (Impact)×(Risk of Exploit)
 - Mission Oriented Risk and Design Analysis (MORDA)

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A Count of Serious Vulnerabilities Can be Misleading

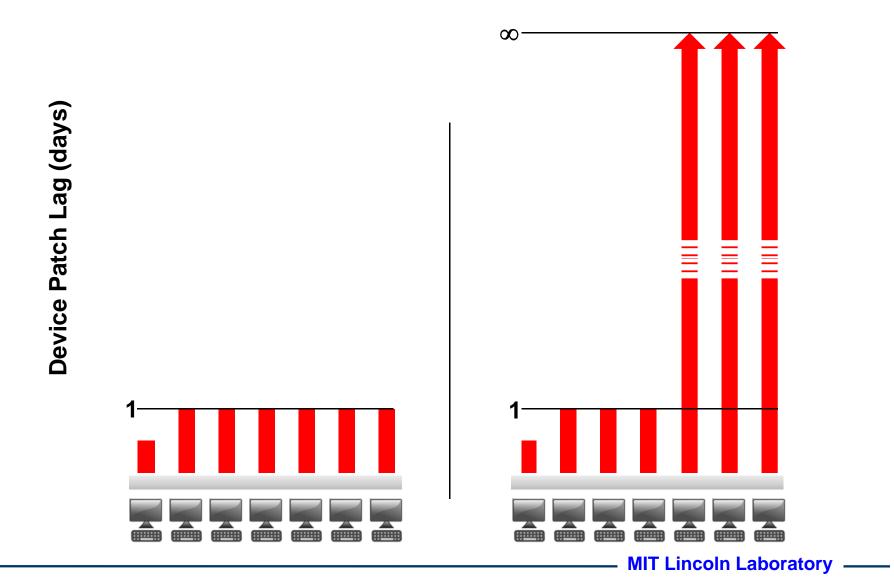




One machine with twenty serious vulnerabilities Twenty machines each with one serious vulnerability

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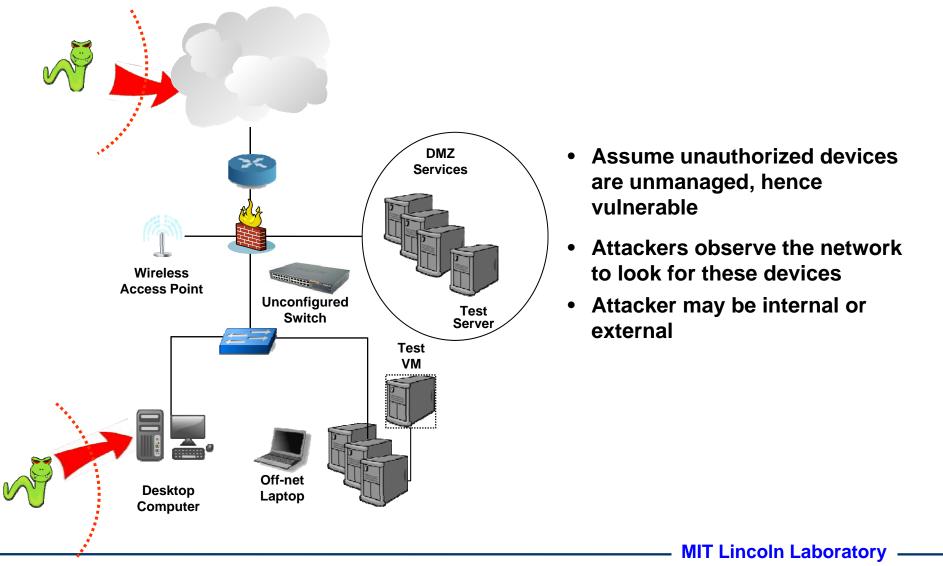




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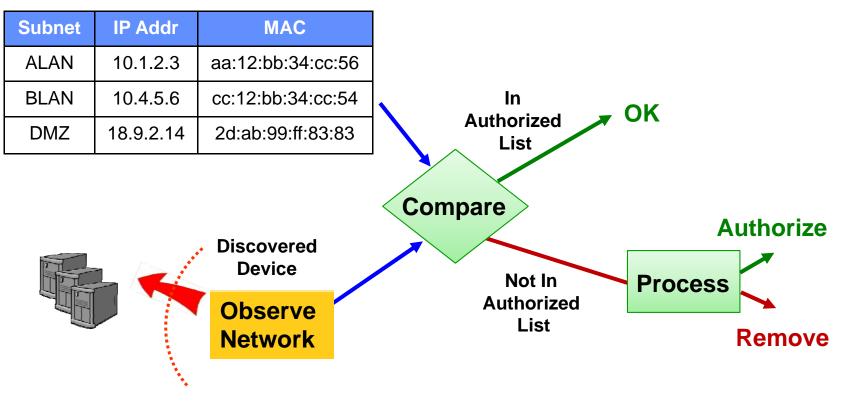


One Attack Model in LR-1 is Attackers Looking for and Compromising Insecure Unauthorized Devices



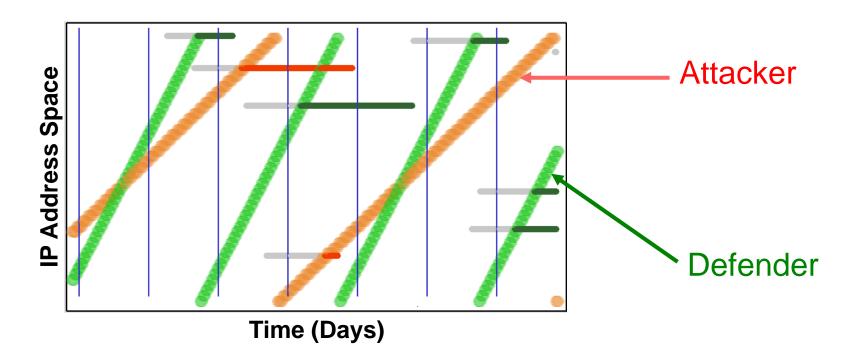
Defenders Continuously Search for and Process Discovered Unauthorized Devices

Authorized Device List





We can Compute the Probability of Detecting a Finite Duration Event by Scanning



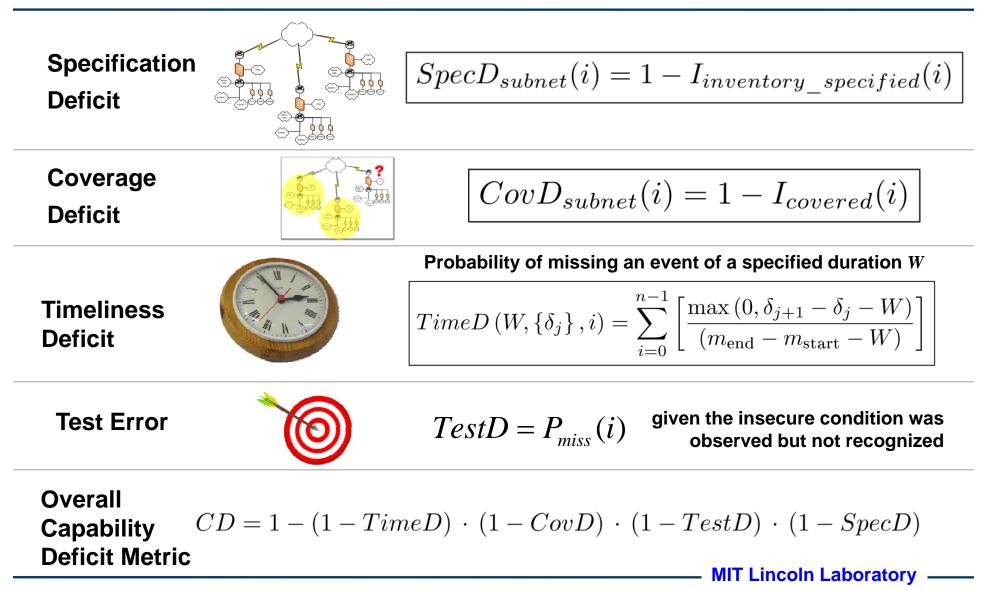
• The probability of detection of an event of duration w with a scan interval δ is given by

$$P_{\text{Observe}}(w,\delta) = \min\left(1,\frac{w}{\delta}\right)$$

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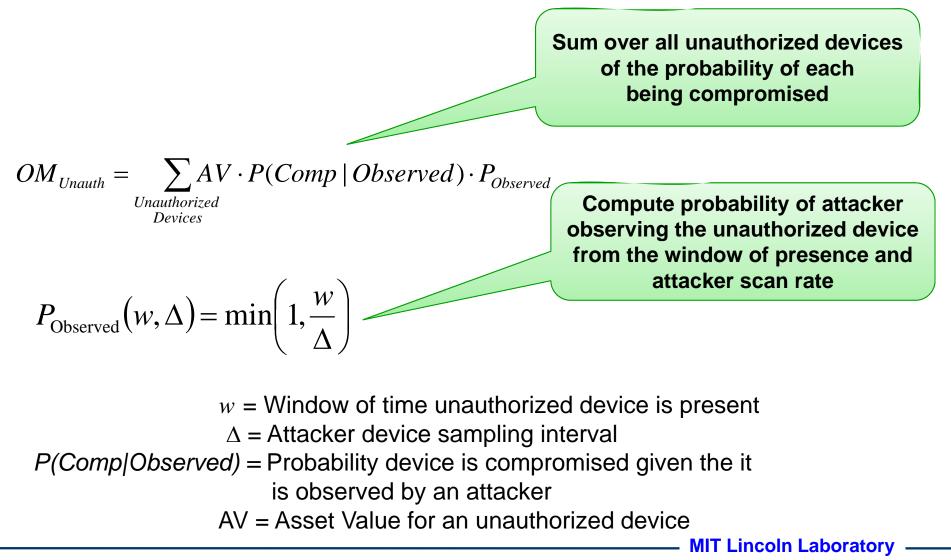


LR-1 Capability Deficit Metric Components





The LR-1 Operational Metric Is the Asset Value of the Expected Compromised Unauthorized Devices

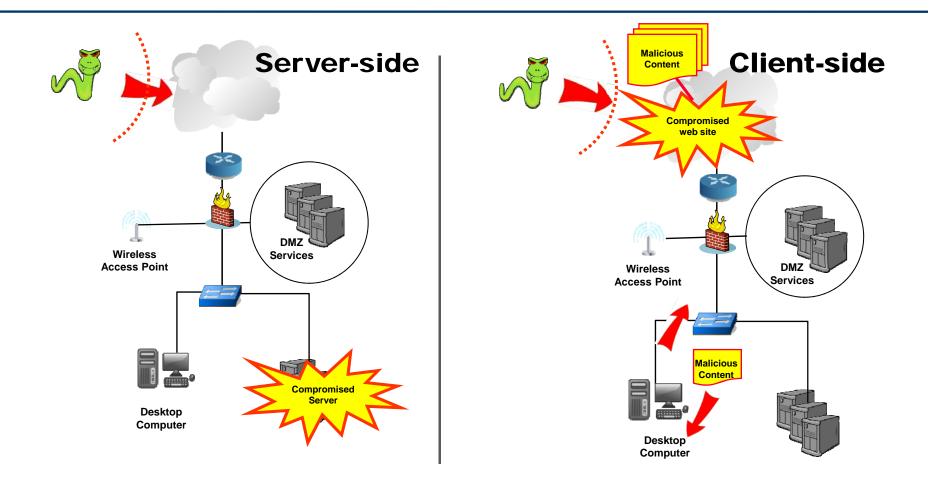




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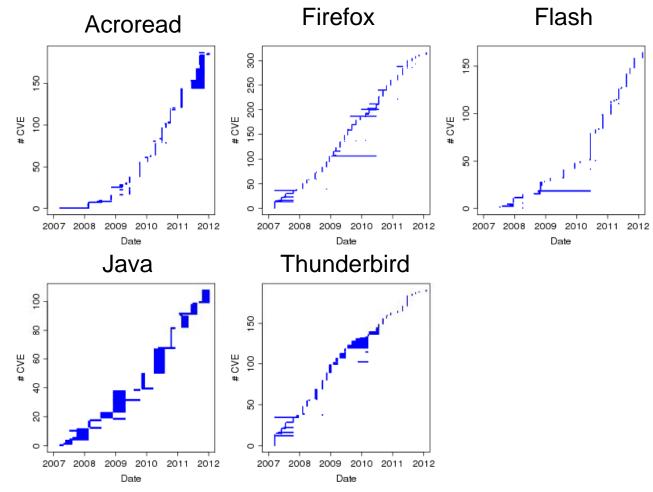


Server and Client-Side Attack Models for Exploitation of Known Vulnerabilities





Client-Side Vulnerabilities Are Discovered From 20 to 60 Times Per Year for Many Client Applications



 Vulnerability scanners and patch tools are updated following publication and patch release dates
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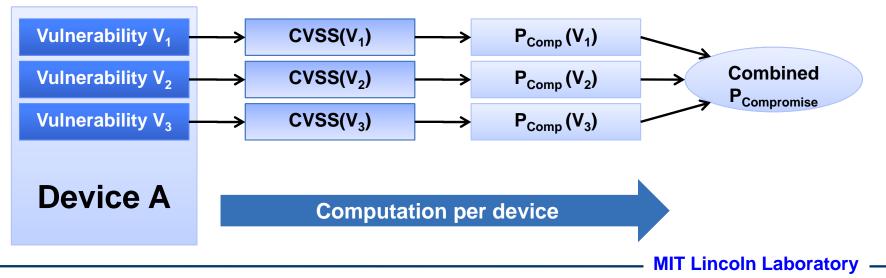


We Compute the Probability of Compromising a Device for Each Vulnerability using Its CVSS Score

 Assume that the probability of compromising a device by exploiting vulnerability v depends on its Common Vulnerability Scoring System (CVSS) score as

 $P_{Compromise}(v) = \left(\frac{CVSS(v)}{10}\right)^2$

 How do you compute the probability of compromise with multiple vulnerabilities?



The Approach Used to Combine Vulnerabilities Depends on the Attacker Model

P _{Compromise}	Attacker Model
$1 - \prod \left(1 - P_i\right)$	 Noisy Rich Attacker Attacker tries all available vulnerabilities until the device is successfully compromised
$\max\left(P_i\right)$	 Stealthy Rich Attacker Attacker tries only the single vulnerability with the highest probability of success
$\sum P_i/N$	 Random Attacker Attacker tries to exploit one vulnerability selected at random

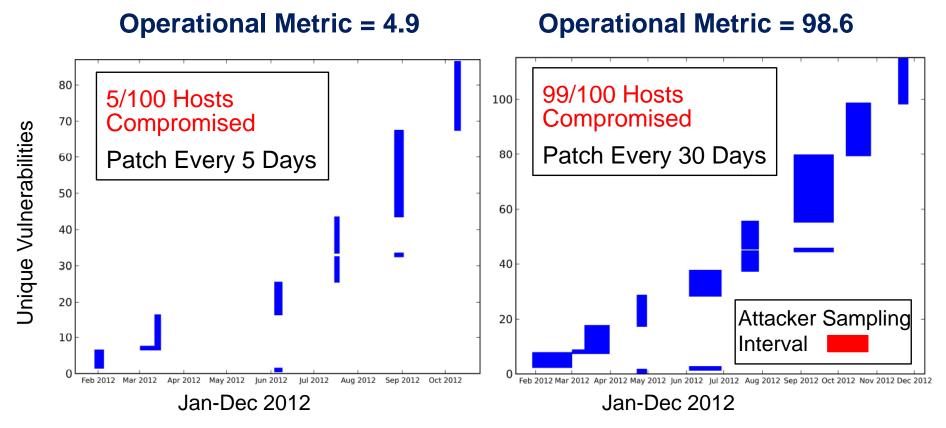
The LR-3 Operational Metric is the Expected Captured Asset Value across Devices

$$OM = \sum_{i \in Devices} AV(i) \left\{ 1 - \prod_{v \in Vulns} (1 - P_{Comp}(v, i)) \right\}$$
Noisy rich attacker on all devices
$$P_{Comp}(v, i) = P_{Compromised | Observed}(v) P_{Observed}(v)$$
Probability of single vulnerability detection and compromise
$$P_{Compromise| Observed}(v) = \left(\frac{cvss(v)}{10}\right)^2$$
Probability of a successful single vulnerability compromise
$$P_{Observed}(v, i) = \min\left(1, \frac{w_i(v)}{\Delta}\right)$$
Probability of an attacker discovering a vulnerability

 $w_i(v)$ = Window of time vulnerability v is present on device i Δ = Attacker device sampling interval for vulnerability AV(i) = Asset value for device i

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- Simulation has 100 Hosts each with an asset value of 1 running only Firefox
- Users browse to a malicious web site once every 30 days
- Attackers require one week after publication to field exploits on web sites
- Noisy rich attackers have exploits for all vulnerabilities

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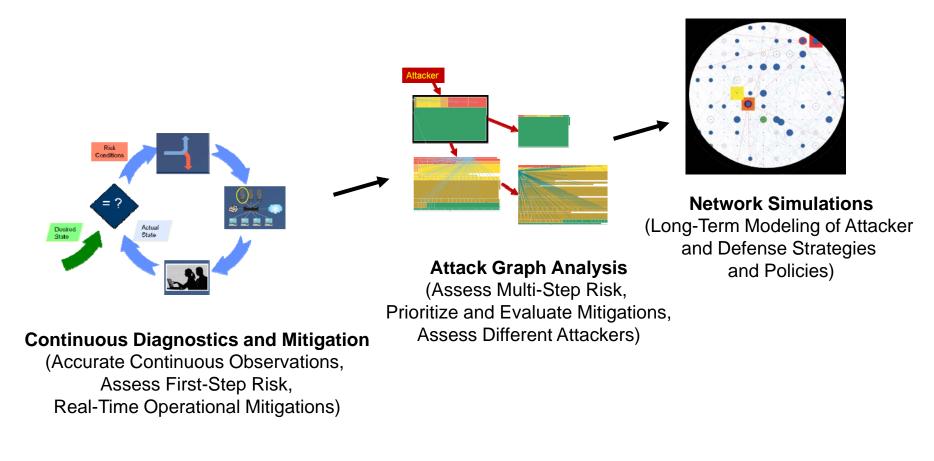
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- The U.S. Department of Homeland Security (DHS) is implementing a Continuous Diagnostics and Mitigation (CDM) strategy for protecting government networks
- We will be creating metrics for 15 capabilities
- Each metric:
 - Includes up to date attacker models
 - Estimates risk from attackers
 - Includes a capability deficit component to determine if risk computations are accurate
- We are completing descriptions for the first nine metrics
- These will be used by the DHS to support continuous monitoring and risk mediation



Roadmap for the Future



Security Maturity Level —

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